DIX

respect to a first axis oriented perpendicular to said new sputter surface, a substrate carrier which is arranged to be drivingly rotatable about a second axis, wherein said first and said second axes are oblique with respect to one another at an angle of less than 90°, and said sputtering source is a magnetron sputtering source with at least one closed loop, tunnel-shaped magnetic field pattern around said first axis with constant field polarity as viewed in a direction along said closed loop.

47. (Amended) The chamber of claim 35, wherein said new sputter surface is substantially rotationally symmetrical with respect to said first axis and has a diameter Φ_T and wherein a locus of smallest mutual spacing of said first and of said second axes has a distance D to said new sputter surface and wherein $3/4 \le \Phi_T$ /D ≤ 2 .

48. (Amended) The chamber of claim 47, wherein $\Phi_{\rm T}$ equals approximately 1.2 D.

Dry

50. (Amended) The chamber of claim 49, further comprising at least one of said substrate on said receiving surface, said locus being situated at least approximately on a plane defined by a surface of said at least one substrate to be sputter coated.